

Description

Semicoa Semiconductors offers:

- Screening and processing per MIL-PRF-19500 Appendix E
- JAN level (2N3485AJ)
- JANTX level (2N3485AJX)
- JANTXV level (2N3485AJV)
- QCI to the applicable level
- 100% die visual inspection per MIL-STD-750 method 2072 for JANTXV
- Radiation testing (total dose) upon request

Applications

- General purpose switching
- Low power
- PNP silicon transistor



Features

- Hermetically sealed TO-46 metal can
- Also available in chip configuration
- Chip geometry 0600
- Reference document: MIL-PRF-19500/392

Benefits

- Qualification Levels: JAN, JANTX, and JANTXV
- Radiation testing available

Absolute Maximum Ratings

T_C = 25°C unless otherwise specified

Parameter	Symbol	Rating	Unit
Collector-Emitter Voltage	V _{CEO}	60	Volts
Collector-Base Voltage	V _{CBO}	60	Volts
Emitter-Base Voltage	V _{EBO}	5	Volts
Collector Current, Continuous	I _C	600	mA
Power Dissipation, T _A = 25°C Derate linearly above 37.5°C	P _T	0.5 3.08	mW mW/°C
Power Dissipation, T _C = 25°C Derate linearly above 25°C	P _T	2.0 11.43	mW mW/°C
Thermal Resistance	R _{0JA} R _{0JC}	0.325 87	°C/W
Operating Junction Temperature Storage Temperature	T _J T _{STG}	-65 to +200	°C

ELECTRICAL CHARACTERISTICS

 characteristics specified at $T_A = 25^\circ\text{C}$
Off Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Collector-Emitter Breakdown Voltage	$V_{(\text{BR})\text{CEO}}$	$I_C = 10 \text{ mA}$	60			Volts
Collector-Base Cutoff Current	$I_{\text{CBO}1}$ $I_{\text{CBO}2}$ $I_{\text{CBO}3}$	$V_{\text{CB}} = 60 \text{ Volts}$ $V_{\text{CB}} = 50 \text{ Volts}$ $V_{\text{CB}} = 50 \text{ Volts}, T_A = 150^\circ\text{C}$			10 10 10	μA nA μA
Emitter-Base Cutoff Current	$I_{\text{EBO}1}$ $I_{\text{EBO}2}$	$V_{\text{EB}} = 5 \text{ Volts}$ $V_{\text{EB}} = 3.5 \text{ Volts}$			10 50	μA nA

On Characteristics

 Pulse Test: Pulse Width = 300 μs , Duty Cycle $\leq 2.0\%$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
DC Current Gain	$h_{\text{FE}1}$	$I_C = 0.1 \text{ mA}, V_{\text{CE}} = 10 \text{ Volts}$	40			
	$h_{\text{FE}2}$	$I_C = 1.0 \text{ mA}, V_{\text{CE}} = 10 \text{ Volts}$	40			
	$h_{\text{FE}3}$	$I_C = 10 \text{ mA}, V_{\text{CE}} = 10 \text{ Volts}$	40			
	$h_{\text{FE}4}$	$I_C = 150 \text{ mA}, V_{\text{CE}} = 10 \text{ Volts}$	40			
	$h_{\text{FE}5}$	$I_C = 500 \text{ mA}, V_{\text{CE}} = 10 \text{ Volts}$	40			
	$h_{\text{FE}6}$	$I_C = 1.0 \text{ mA}, V_{\text{CE}} = 10 \text{ Volts}$ $T_A = -55^\circ\text{C}$	20		120	
Base-Emitter Saturation Voltage	$V_{\text{BEsat}1}$ $V_{\text{BEsat}2}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$ $I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$			1.3 2.6	Volts
Collector-Emitter Saturation Voltage	$V_{\text{CEsat}1}$ $V_{\text{CEsat}2}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$ $I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$			0.4 1.6	Volts

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Magnitude – Common Emitter, Short Circuit Forward Current Transfer Ratio	$ h_{\text{FE}} $	$V_{\text{CE}} = 20 \text{ Volts}, I_C = 50 \text{ mA}, f = 100 \text{ MHz}$	2.0		10	
Small Signal Short Circuit Forward Current Transfer Ratio	h_{FE}	$V_{\text{CE}} = 10 \text{ Volts}, I_C = 1 \text{ mA}, f = 1 \text{ kHz}$	40			
Open Circuit Output Capacitance	C_{OBO}	$V_{\text{CB}} = 10 \text{ Volts}, I_E = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			8	pF
Open Circuit Input Capacitance	C_{IBO}	$V_{\text{EB}} = 2 \text{ Volts}, I_C = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			30	pF

Switching Characteristics

Saturated Turn-On Time	t_{ON}				45	ns
Saturated Turn-Off Time	t_{OFF}				175	ns